

**Search Notes**

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Examiner

THANH LAM

Applicant(s)/Patent under  
Reexamination

OSAWA ET AL.

Art Unit

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	179,184,2 33-234, 198	11/23/2008	TL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference searched		11/23/2008	TL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventors & update searched	8/15/2009	TL